## Notice of References Cited Application/Control No. 10/564,423 Examiner ENAM AHMED Applicant(s)/Patent Under Reexamination FIFIELD ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,192,422	02-2001	Daines et al.	710/29
*	В	US-6,851,086	02-2005	Szymanski, Ted	714/781
*	С	US-5,339,316	08-1994	Diepstraten, Wilhelmus J. M.	370/401
*	D	US-6,845,089	01-2005	Gu et al.	370/337
*	Е	US-4,722,054	01-1988	Yorozu et al.	705/17
*	F	US-2005/0241710	11-2005	Early et al.	138/089
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

	NON-I ATENT BOOOMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
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	х						

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